



## EE 232 Lightwave Devices Lecture 2: Basic Concepts of Lasers

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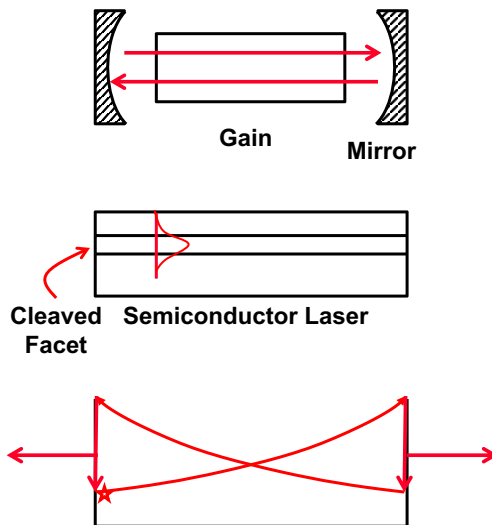
University of California, Berkeley  
Electrical Engineering and Computer Sciences Dept.

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## Basic Concept of Lasers



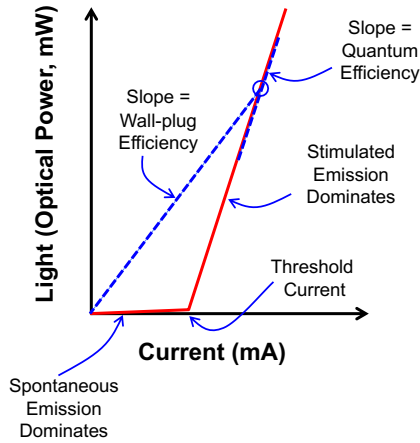
- Laser:
  - Light Amplification by Stimulated Emission of Radiation
- Basic elements:
  - Gain media
  - Optical cavity
- Threshold condition:
  - Bias point where laser starts to “lase”
  - Gain (nearly) equals loss

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## L-I Curve of Semiconductor Lasers



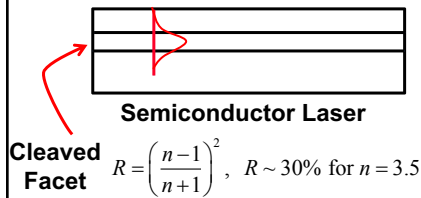
- Distinctive threshold (at least in classical lasers)
- Semiconductor laser is a forward-biased p-n junction, so mainly a current-biased device
- Threshold current :
  - Minimum current at which the laser starts to “lase”
- Quantum efficiency
  - “Differential” electrical-to-optical conversion efficiency, i.e., how many photons generated by injected electrons beyond threshold
- Wall-plug efficiency
  - Total electrical-to-optical conversion efficiency

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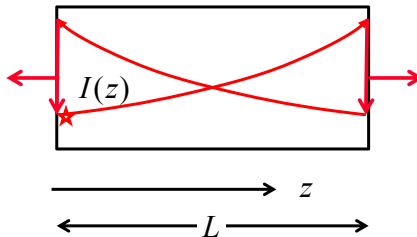
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## “Edge-Emitting” Semiconductor Lasers



$$R = \left( \frac{n-1}{n+1} \right)^2, \quad R \sim 30\% \text{ for } n = 3.5$$



$g$  : gain coefficient [ $\text{cm}^{-1}$ ]

Light amplification:  $I(z) = I_0 e^{\Gamma g z}$

$\Gamma$  : confinement factor  
(fraction of energy in gain media)

Threshold condition:

Round-trip gain = 1

$$e^{\Gamma g L - \alpha_i L} R_1 e^{\Gamma g L - \alpha_i L} R_2 = 1$$

$$g = g_{th} = \frac{\alpha_i}{\Gamma} + \frac{1}{2\Gamma L} \ln \left( \frac{1}{R_1 R_2} \right) = \frac{\alpha_i + \alpha_m}{\Gamma}$$

$$\begin{cases} \alpha_i : \text{intrinsic loss} \\ \alpha_m = \frac{1}{2L} \ln \left( \frac{1}{R_1 R_2} \right) : \text{mirror loss (i.e., output light)} \end{cases}$$

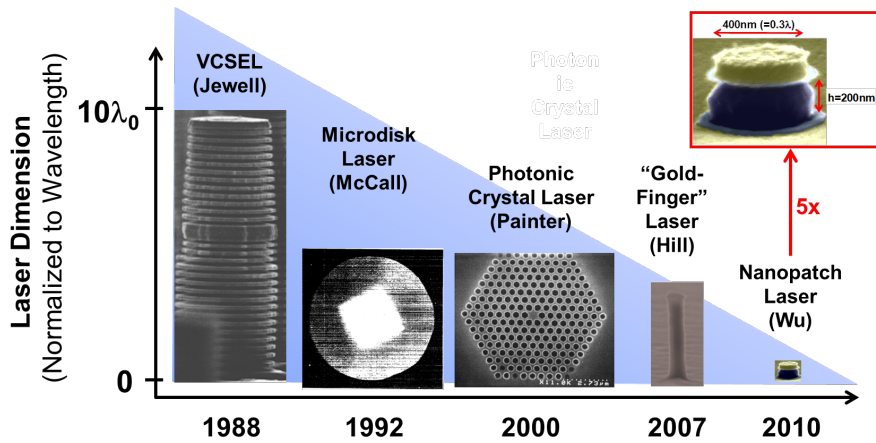
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## Modern Lasers

- Optical cavity does not necessarily consist of mirrors

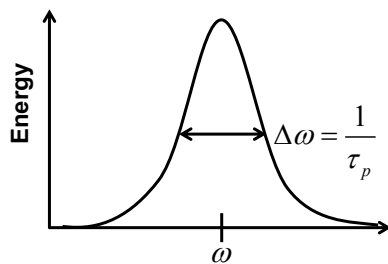
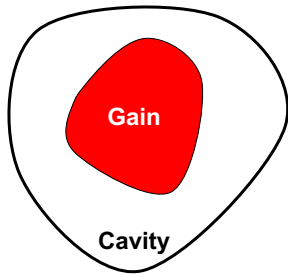


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## Generic Description of Optical Cavity



Quality Factor:

$$Q = \frac{\text{Energy Stored}}{\text{Energy Dissipated per Cycle}}$$

$$Q = \frac{\omega}{\Delta\omega}$$

$$\Delta\omega = \frac{1}{\tau_p}$$

$\tau_p$ : photon lifetime [sec]

$$\frac{1}{\tau_p} = \alpha \frac{c}{n} \quad \left( \begin{array}{l} \alpha: \text{loss rate per cm} \\ 1/\tau_p: \text{loss rate per sec} \end{array} \right)$$

$$Q = \omega\tau_p$$

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## Photon Lifetime and Spectral Width

Decay of optical energy when input is turned off  
(ring-down measurement):

$$I(t) = I_0 e^{-t/\tau_p} \quad \text{for } t \geq 0$$

Electrical (optical) field:

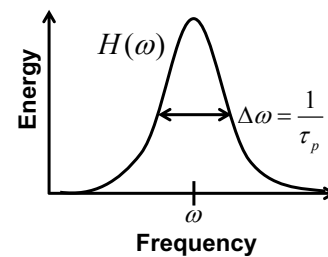
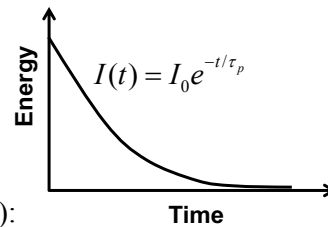
$$E(t) = E_0 e^{j\omega_0 t} e^{-t/2\tau_p} \quad \text{for } t \geq 0$$

Frequency domain response (Fourier transform):

$$H(\omega) = \int_0^{\infty} e^{j\omega_0 t} e^{-t/2\tau_p} e^{-j\omega t} dt = \frac{1}{j(\omega - \omega_0) + 1/2\tau_p}$$

$$\text{FWHM of } |H(\omega)|^2: \quad \omega - \omega_0 = \pm \frac{1}{2\tau_p}$$

$$\Delta\omega = \frac{1}{\tau_p}$$

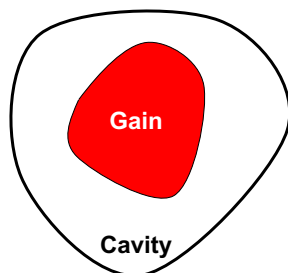


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## Threshold Condition of Generic Lasers

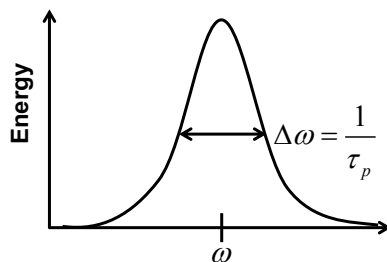


Gain = Loss

(rate of gain = rate of loss)

$$\Gamma g_{th} \frac{c}{n} = \frac{1}{\tau_p} = \frac{\omega}{Q}$$

$$g_{th} = \frac{\omega n}{Q \Gamma c}$$



Quantum efficiency:

$$\eta = \frac{\alpha_m}{\alpha_m + \alpha_i} = \frac{Q_{rad}^{-1}}{Q_{rad}^{-1} + Q_{loss}^{-1}} = \frac{Q_{rad}}{Q}$$

$$\eta = \frac{Q}{Q_{rad}}$$

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## Typical Q of Semiconductor Laser

Edge-emitting laser:

$$L = 100\mu\text{m}, R = 30\%, \omega \sim 100\text{THz}, \tau_p \sim 1\text{ps}, Q \sim 600$$

Vertical Cavity Surface-Emitting Laser (VCSEL)

$$L = 1\mu\text{m}, R = 99\%, Q \sim 700$$

Microdisk (Whispering Gallery Mode or WGM) Laser

$$Q \sim 1000 \text{ (up to } 10^{11} \text{ possible in low loss materials)}$$

Photonic crystal laser:  $Q \sim 1000$  (up to  $10^6$  possible)

Metal cavity laser (plasmonic laser):  $Q \sim 10$  to 100

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## Gain Cross-Section

Gain cross-section (instead of gain coefficient) is often used to measure the gain in gas or solid-state lasers:

$$\sigma : [\text{cm}^2]$$

Gain cross-section is related to gain by:

$$g = N\sigma$$

where  $N$  is concentration of active molecules

For comparison, in semiconductor lasers:

$$g \sim 100 \text{ cm}^{-1}$$

$$N \sim 10^{18} \text{ cm}^{-3} \text{ (typical electron concentration at threshold)}$$

$$\sigma \sim 10^{-16} \text{ cm}^2 \text{ (= } (0.1\text{nm})^2 \text{ )}$$

Note: more precise relation between gain and carrier concentration will be discussed in future lectures

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